EPISTAR

ES-VEBCF08V

InGaN F-series Blue LED Chip

> Mechanical Specification:

(1) Dimension

- Chip size: 8 mil x 17 mil (192 \pm 25 μ m x 432 \pm 25 μ m)

- Thickness:4.3mil (110 \pm 10 $\mu m)$

- P bonding pad: 3.5mil (90 \pm 10 μ m) - N bonding pad: 3.5mil (90 \pm 10 μ m)

(2) Metallization

Topside P electrode: Au alloyTopside N electrode: Au alloy

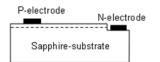
Features:

- · High radiant flux
- · Long operation life
- · Lambertian radiation

Applications:

Automotive





> Electro-optical Characteristics at 25°C: (1)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Forward Voltage	Vf1	If = 10μA	1.6	-	-	V
	Vf2	If = 60mA	-	3.2	3.4	V
Reverse Current	Ir	Vr = 5V	-	-	1.0	μΑ
Dominant Wavelength ⁽²⁾	λd	If = 60mA	450	-	460	nm
Spectra Half-width	Δλ	If = 60mA	-	25	-	nm
Radiant Flux ⁽³⁾⁽⁴⁾	Ро	If = 60mA	80	-	85	
			85	-	90	mW
			90	-	95	
			95	-	100	

Note:

(1) ESD protection during chip handling is recommended.

(4) Radiant flux measurement allows a tolerance of $\pm 15\%$.

⁽²⁾ Basically, the wavelength span is 10nm; however, customers' special requirements are also welcome.

⁽³⁾ Radiant flux is determined by using an Ag-plated TO-can header without an encapsulant.

> Absolute Maximum Ratings:

Parameter	Symbol	Condition	Rating	Unit
Forward DC Current	If	Ta = 25°C	≤80	mA
Reverse Voltage	Vr	Ta = 25°C	≤ 5	V
Junction Temperature	Tj	-	≤ 125	°C
ESD withstand voltage(HBM) ⁽²⁾	VESD	-	Up to 2	KV
		Chip	-40 ~ +85	°C
Storage Temperature	Tstg	Chip-on-tape/storage	5~35	°C
		Chip-on-tape/transportation	-20 ~ +65	°C
Temperature during Packaging	-	-	280(<10sec)	°C

Note: (1) Maximum ratings are package dependent. The above maximum ratings were determined using a Printed Circuit Board (PCB) without an encapsulant. Stresses in excess of the absolute maximum ratings such as forward current and junction temperature may cause damage to the LED.

(2) According to ANSI/ESDA/JEDEC JS-001.

> Characteristic Curves:

Fig.1 - Relative luminous Intensity vs. Forward Current

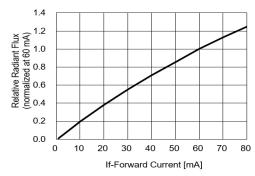


Fig.3 – Relative Intensity (@60mA) vs. Ambient Temperature

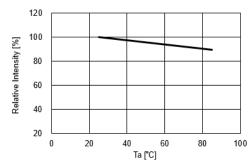


Fig.5 – Dominant Wavelength (@60mA) vs. Ambient Temperature

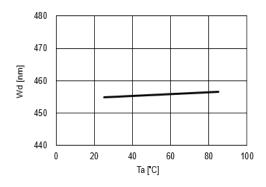


Fig.2 - Forward Current vs. Forward Voltage

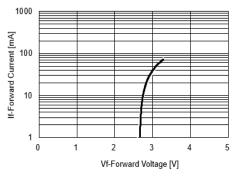


Fig.4 – Forward Voltage (@60mA) vs. Ambient Temperature

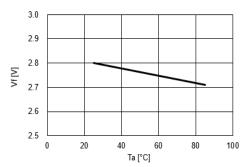
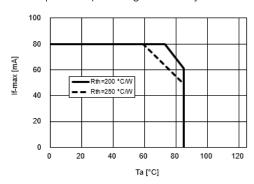


Fig.6 – Maximum Driving Forward DC Current vs. Ambient Temperature (De-rating based on Tj max. = 125°C)



> Qualification:

> Revision:

Version	Page	Subjects	Date of Modification
A	3	Initial Release	December 30, 2020

¹⁾ EPISTAR's LED chips and epi-wafers are designed and manufactured according to the quality management system that complies to the IATF 16949:2016 requirements (IATF No: 0325277/ Certificate Registration No: 20000910 IATF 16).

²⁾The chip qualification test plan is performed under certain test items suggested by AEC-Q102.